

Search Notes

Application/Control No.

10/814,572

Examiner

HABTE MERED

Applicant(s)/Patent under
Reexamination

MITCHELL ET AL.

Art Unit

2474

SEARCHED

Class	Subclass	Date	Examiner
370	218	12/18/2010	HM
370	219	12/18/2010	HM
370	230	12/18/2010	HM
370	217	12/18/2010	HM
370	220	12/18/2010	HM
370	216	12/18/2010	HM
370	225-228	12/18/2010	HM
370	245	12/18/2010	HM
714	4,40	12/18/2010	HM
709	201	12/18/2010	HM
709	245	12/18/2010	HM
709	225	12/18/2010	HM
709	231	12/18/2010	HM
709	239	12/18/2010	HM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Limited text Search in EAST DB:USPAT, USPG-PUB, JPO, and EPO	12/18/2010	HM
Searched Palm Inventor's DB	5/20/2009	HM
Searched IEEE	5/20/2009	HM
Limited text search of all classes/sub- classes listed above	12/18/2010	HM
Limited text search of all classes/sub- classes listed above	7/3/2011	HM
Text Searched IEEE and EAST (ALL DBs)	7/3/2011	HM